

Search Notes

Application/Control No.

10/664,834

Examiner

Seung H. Lee

Applicant(s)/Patent under
Reexamination

FENG, CHEN

Art Unit

2876

SEARCHED

Class	Subclass	Date	Examiner
235	454	7/21/2005	SHL
323	267	7/21/2005	SHL
363	72	7/21/2005	SHL
235	472.01	7/21/2005	SHL
235	462.10	7/21/2005	SHL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Same	As Above	7/21/2005	SHL

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	7/21/2005	SHL
NPL	7/21/2005	SHL